

Search Notes

Application/Control No.

10/821,500

Examiner

Jezia Riley

Applicant(s)/Patent under
Reexamination

SHEN ET AL.

Art Unit

1637

SEARCHED

Class	Subclass	Date	Examiner
536	26.6		
544	232,277		
546	23,24,113		
435	6,91.1		
430	56	6/6/2007	JR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
536	26.6		
544	232,277		
546	23,24,113		
435/6,91.1 430/56		6/6/2007	JR

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
stn search enclosed	6/4/2007	JR